## Fabrication of photonic crystals in InP by Cl<sub>2</sub>-based inductively coupled plasma etching using sidewall passivation

R. van der Heijden<sup>a</sup>, C.F. Carlström<sup>a</sup>, E. van der Drift<sup>b</sup>, R.W. van der Heijden<sup>a</sup>, F. Karouta<sup>a</sup>, H.W.M. Salemink<sup>a,b</sup>.

<sup>a</sup>COBRA Inter-University Research Institute and Center for NanoMaterials, Eindhoven University of Technology, PO Box 513, 5600 MB, Eindhoven, The Netherlands. <sup>b</sup>Kavli Institute of Nanoscience, Delft University of Technology, P.O. Box 5053, 2600 GB Delft, The Netherlands.

Deep etching of two-dimensional photonic crystals in InP-based planar waveguides has been performed by state-of-the-art techniques as chemically assisted ion beam etching

(CAIBE) [1] and inductively coupled plasma (ICP) etching [2], the latter being more suitable for large scale production. We present new sidewall passivation processes in Cl<sub>2</sub>-based ICP-etching to obtain holes with straight and vertical sidewalls. With this technique we are able to etch holes with a diameter of ~240 nm down to a depth of 3.4  $\mu$ m, the shape being nearly cylindrical in the upper 2.5  $\mu$ m, see fig 1.

Figure 1: SEM view of the etched holes.

- [1] M.V. Kotlyar et.al., Appl. Phys. Let. **84**, 3588, 2004; M. Mulot et. al., J. Vac. Sci. Technol. B **22**, 707, 2004.
- [2] F. Pommereau et. al., J. Appl. Phys. **95**, 2242, 2004.